

Model 3708 8-Channel Preamp and Scanner

FOR ULTRA-LOW NOISE RESISTANCE MEASUREMENTS

For many years, the Linear Research Model LR-700 AC resistance bridge had been revered as the industry standard for ultra-low noise AC resistance measurements. Since Linear Research ceased operations in 2005, there had not been a commercially available instrument able to parallel the real-world, low noise measurement performance of the Model LR-700.

Lake Shore obtained the remaining stock of field-effect transistors (FETs) used in the Model LR-700 that were selected for their unique, low-voltage noise characteristics. These FETs enabled us to develop the Model 3708 8-channel preamp and scanner. When combined with the exclusive design attributes of our Model 372 AC resistance bridge, the Model 3708 offers an exceptionally low voltage noise floor specification of just $2 \text{ nV}_{\text{RMS}}/\sqrt{\text{Hz}}$. This is equivalent to the low noise measurement performance previously only available with the Model LR-700.



How Good is the Model 3708 Preamp and Scanner?

The noise specification across a single FET used in the Model 3708 preamp and scanner is $0.62 \text{ nV}_{\text{RMS}}/\sqrt{\text{Hz}}$. Sixteen of these FETs, along with additional instrument circuitry, contribute to the overall instrument voltage noise floor performance. The practical measure of voltage noise is given by the resolution of the instrument, which is a function of the specified resistance range and excitation level.

The following table compares the Model LR-700 directly with the Model 372/3708 as each is observed using a digital readout or computer interface. The Model LR-700 specifications were compiled using mid-scale, room temperature resistors and a 10 second filter, while the Model 372/3708 specifications were compiled using an 18 second filter. The Model 372/3708 specifications were, however, normalized to 10 second filtering by multiplying the 18 second noise figure by $\sqrt{(18/10)}$, or 1.34.

Comparison of Linear Research LR-700 and Lake Shore Model 372/3708 instrument specifications for measurements performed under equivalent conditions

Resistance range (Ω)	Linear Research Model LR-700		Lake Shore Model 372/3708	
	Resolution	Excitation	Resolution	Excitation
0.002	10 n Ω	30 μV	10 n Ω	30 μV
0.02	100 n Ω	300 μV	54 n Ω	300 μV
0.2	1 $\mu\Omega$	300 μV	540 n Ω	300 μV
2	10 $\mu\Omega$	300 μV	5.4 $\mu\Omega$	300 μV
20	100 $\mu\Omega$	300 μV	54 $\mu\Omega$	300 μV
200	1 m Ω	10 mV	270 $\mu\Omega$	3 mV
2,000	10 m Ω	10 mV	2.7 m Ω	3 mV
20,000	100 m Ω	10 mV	27 m Ω	3 mV
200,000	1 Ω	10 mV	540 m Ω	3 mV
2,000,000	10 Ω	10 mV	7.3 Ω	3 mV

Which Lake Shore Scanner is Best for Your Particular Requirements?

At Lake Shore, we are committed to offering instrumentation optimized for your particular needs. As such, we offer two different scanner options for use with the Model 372 AC resistance bridge, each customized for particular measurement requirements. These are the Model 3708 and the Model 3726. The scanners allow the single channel Model 372 to multiplex up to either 8 or 16 channels. Beyond these common features, the scanners are differentiated by their respective input voltage noise and DC bias current.

Ultra-low resistance measurement applications that demand the very best in low noise performance require the **Model 3708** preamp and scanner. At just $2 \text{ nV}_{\text{RMS}}/\sqrt{\text{Hz}}$, the Model 3708 offers the lowest input voltage noise. However, it is not recommended for ultra-low temperature measurements. These measurements require very low DC bias current to prevent measurement errors as a result of self heating.

At just 4 pA, the **Model 3726** scanner offers exceptionally low DC bias current. It is designed to provide femtowatt excitation levels, so it is the best choice for applications below 50 mK. The higher input voltage noise floor of $10 \text{ nV}_{\text{RMS}}/\sqrt{\text{Hz}}$ is not optimal for AC resistance measurements, but is a surmountable factor for sub-Kelvin measurement applications.



Scanner comparison

	Model 3708	Model 3726
Noise	$2 \text{ nV}_{\text{RMS}}/\sqrt{\text{Hz}}$	$10 \text{ nV}_{\text{RMS}}/\sqrt{\text{Hz}}$
DC bias current	55 pA + 1% I_{EXC}	4 pA + 1% I_{EXC}
Channels	8	16

Ordering Information

Part number	Description
372N	AC resistance bridge and temperature controller
372S	AC resistance bridge with 3726 scanner and standard 3 m (10 ft) connection cable
372S-6	AC resistance bridge with 3726 scanner and standard 6 m (20 ft) connection cable
372S-10	AC resistance bridge with 3726 scanner and standard 10 m (33 ft) connection cable
372U	AC resistance bridge with 3708 scanner and standard 3 m (10 ft) connection cable
372U-6	AC resistance bridge with 3708 scanner and standard 6 m (20 ft) connection cable
372U-10	AC resistance bridge with 3708 scanner and standard 10 m (33 ft) connection cable
3726	16-channel scanner with standard 3 m (10 ft) connection cable (Model 372 only)
3726-6	16-channel scanner with 6 m (20 ft) connection cable (Model 372 only)
3726-10	16-channel scanner with 10 m (33 ft) connection cable (Model 372 only)
3708	Ultra-low resistance 8-channel scanner with standard 3 m (10 ft) connection cable
3708-6	Ultra-low resistance 8-channel scanner with 6 m (20 ft) connection cable
3708-10	Ultra-low resistance 8-channel scanner with 10 m (33 ft) connection cable

Model 3708 Performance Specification Table

		Voltage Range							
		6.32 mV	2.0 mV	632 μ V	200 μ V	63.2 μ V	20 μ V	6.32 μ V	2.0 μ V
Current Excitation	31.6 mA	200 m Ω 200 n Ω 100 μ W	63.2 m Ω 63 n Ω 32 μ W	20 m Ω 40 n Ω 10 μ W	6.32 m Ω 13 n Ω 3.2 μ W	2.0 m Ω 10 n Ω 1.0 μ W	632 μ Ω 10 n Ω 320 nW	200 μ Ω 10 n Ω 100 nW	20 μ Ω 10 n Ω 32 nW
	10 mA	632 m Ω 630 n Ω 32 μ W	200 m Ω 200 n Ω 10 μ W	63.2 m Ω 130 n Ω 3.2 μ W	20 m Ω 40 n Ω 1.0 μ W	6.32 m Ω 32 n Ω 320 nW	2.0 m Ω 100 n Ω 100 nW	632 μ Ω 32 n Ω 32 nW	200 μ Ω 32 n Ω 10 nW
	3.16 mA	2.0 Ω 2.0 μ Ω 10 μ W	632 m Ω 630 n Ω 3.2 μ W	200 m Ω 400 n Ω 1.0 μ W	63.2 m Ω 130 n Ω 320 nW	20 m Ω 100 n Ω 100 nW	6.32 m Ω 100 n Ω 32 nW	2.0 m Ω 100 n Ω 10 nW	632 μ Ω 100 n Ω 3.2 nW
	1 mA	6.32 Ω 6.3 μ Ω 3.2 μ W	2.0 Ω 2.0 μ Ω 1.0 μ W	632 m Ω 1.3 μ Ω 320 nW	200 m Ω 400 n Ω 100 nW	63.2 m Ω 320 n Ω 32 nW	20 m Ω 320 n Ω 10 nW	6.32 m Ω 320 n Ω 3.2 nW	2.0 m Ω 320 n Ω 1.0 nW
	316 μ A	20 Ω 20 μ Ω 1.0 μ W	6.32 Ω 6.3 μ Ω 320 nW	2.0 Ω 4.0 μ Ω 100 nW	632 m Ω 1.3 μ Ω 32 nW	200 m Ω 1.0 μ Ω 10 nW	63.2 m Ω 1.0 μ Ω 3.2 nW	20 m Ω 1.0 μ Ω 1.0 nW	6.32 m Ω 1.0 μ Ω 320 pW
	100 μ A	63.2 Ω 63 μ Ω 320 nW	20 Ω 20 μ Ω 100 nW	6.32 Ω 13 μ Ω 32 nW	2.0 Ω 4.0 μ Ω 10 nW	632 m Ω 3.2 μ Ω 3.2 nW	200 m Ω 3.2 μ Ω 1.0 nW	63.2 m Ω 3.2 m Ω 320 pW	20 m Ω 3.2 μ Ω 100 pW
	31.6 μ A	200 Ω 200 μ Ω 100 nW	63.2 Ω 63 μ Ω 32 nW	20 Ω 40 μ Ω 10 nW	6.32 Ω 13 μ Ω 3.2 nW	2.0 Ω 10 μ Ω 1.0 nW	632 m Ω 10 μ Ω 320 pW	200 m Ω 10 μ Ω 100 pW	6.32 m Ω 10 μ Ω 32 pW
	10 μ A	632 Ω 630 μ Ω 32 nW	200 Ω 200 μ Ω 10 nW	63.2 Ω 130 μ Ω 3.2 nW	20 Ω 40 μ Ω 1.0 nW	6.32 Ω 32 μ Ω 320 pW	2.0 Ω 32 μ Ω 100 pW	632 m Ω 32 μ Ω 32 pW	200 m Ω 32 μ Ω 10 pW
	3.16 μ A	2.0 k Ω 2.0 m Ω 10 nW	632 Ω 630 μ Ω 3.2 nW	200 Ω 400 μ Ω 1.0 nW	63.2 Ω 130 μ Ω 320 pW	20 Ω 100 μ Ω 100 pW	6.32 Ω 100 μ Ω 32 pW	2.0 Ω 100 μ Ω 10 pW	632 m Ω 100 μ Ω 3.2 pW
	1.0 μ A	6.32 k Ω 6.3 m Ω 3.2 nW	2.0 k Ω 2.0 m Ω 1.0 nW	632 Ω 1.3 m Ω 320 pW	200 Ω 400 μ Ω 100 pW	63.2 Ω 320 μ Ω 32 pW	20 Ω 320 μ Ω 10 pW	6.32 Ω 320 μ Ω 3.2 pW	2.0 Ω 320 μ Ω 1.0 pW
	316 nA	20 k Ω 20 m Ω 1.0 nW	6.32 k Ω 6.3 m Ω 320 pW	2.0 k Ω 4.0 m Ω 100 pW	632 Ω 1.3 m Ω 32 pW	200 Ω 1.0 m Ω 10 pW	63.2 Ω 1.0 m Ω 3.2 pW	20 Ω 1.0 m Ω 1.0 pW	6.32 Ω 1.0 m Ω 320 fW
	100 nA	63.2 k Ω 63 m Ω 320 pW	20 k Ω 40 m Ω 100 pW	6.32 k Ω 13 m Ω 32 pW	2.0 k Ω 6.0 m Ω 10 pW	632 Ω 3.2 m Ω 3.2 pW	200 Ω 3.2 m Ω 1.0 pW	63.2 Ω 3.2 m Ω 320 fW	20 Ω 3.2 m Ω 100 fW
	31.6 nA	200 k Ω 400 m Ω 100 pW	63.2 k Ω 130 m Ω 32 pW	20 k Ω 60 m Ω 10 pW	6.32 k Ω 20 m Ω 3.2 pW	2.0 k Ω 20 m Ω 1.0 pW	632 Ω 10 m Ω 320 fW	200 Ω 10 m Ω 100 fW	63.2 Ω 10 m Ω 32 fW
	10 nA	632 k Ω 1.9 Ω 32 pW	200 k Ω 600 m Ω 10 pW	63.2 k Ω 200 m Ω 3.2 pW	2.0 k Ω 200 m Ω 1.0 pW	6.32 k Ω 63 m Ω 320 fW	2.0 k Ω 63 m Ω 100 fW	632 Ω 32 Ω 32 fW	200 Ω 32 m Ω 10 fW
	3.16 nA	2.0 M Ω 6.0 Ω 10 pW	632 k Ω 2.0 Ω 3.2 pW	200 k Ω 2.0 Ω 1.0 pW	63.2 k Ω 630 m Ω 320 fW	20 k Ω 600 m Ω 100 fW	6.32 k Ω 200 m Ω 32 fW	2.0 k Ω 200 m Ω 10 fW	632 Ω 100 m Ω 3.2 fW
	1.0 nA	6.32 M Ω ** 3.2 pW	2.0 M Ω 20 Ω 1.0 pW	632 k Ω 6.3 Ω 320 fW	200 k Ω 6.0 Ω 100 fW	63.2 k Ω 3.2 Ω 32 fW	20 k Ω 2.0 Ω 10 fW	6.32 k Ω 630 m Ω 3.2 fW	2.0 k Ω 1.0 Ω 1.0 fW
	316 pA	* * *	6.32 M Ω ** 320 fW	2.0 M Ω 60 Ω 100 fW	632 k Ω 19 Ω 32 fW	200 k Ω 20 Ω 10 fW	63.2 k Ω 6.3 Ω 3.2 fW	20 k Ω 3.0 Ω 1.0 fW	6.32 k Ω 3.2 Ω 320 aW
	100 pA	* * *	*	6.32 M Ω ** 32 fW	2.0 M Ω 200 Ω 10 fW	632 k Ω 63 Ω 3.2 fW	200 k Ω 60 Ω 1.0 fW	63.2 k Ω 32 Ω 320 aW	20 k Ω 20 Ω 100 aW
	31.6 pA	* * *	*	*	6.32 M Ω ** 3.2 fW	2.0 M Ω 600 Ω 1.0 fW	632 k Ω 190 Ω 320 aW	200 k Ω 200 Ω 100 aW	63.2 k Ω 63 Ω 32 aW
	10 pA	* * *	*	*	*	6.32 M Ω ** 320 aW	2.0 M Ω 2.0 k Ω 100 aW	632 k Ω 630 Ω 32 aW	200 k Ω 600 Ω 10 aW
3.16 pA	* * *	*	*	*	*	6.32 M Ω ** 32 aW	2.0 M Ω 6.0 k Ω 10 aW	632 k Ω 1.9 k Ω 3.2 aW	

Accuracy

- $\pm 0.03\% + 0.005\%$ of range
- $\pm 0.05\% + 0.008\%$ of range
- $\pm 0.1\% + 0.015\%$ of range
- $\pm 0.3\% + 0.05\%$ of range
- $\pm 0.5\% + 0.08\%$ of range
- $\pm 1.0\% + 0.15\%$ of range

* Range not available
** Range available, not specified

200 k Ω — resistance range
100 Ω — resolution
1.0 fW — power

Resistance Range: Full scale resistance range, nominal 20% over range
Resolution: RMS noise with 18 s filter settling time (approximates 3 s analog time constant)
Power: Excitation power at one-half full scale resistance

Precision: Dominated by measurement temperature coefficient ($\pm 0.0015\%$ of reading $\pm 0.0002\%$ of range)/ $^{\circ}$ C



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Established in 1968, Lake Shore Cryotronics, Inc. is an international leader in developing innovative measurement and control solutions. Founded by Dr. John M. Swartz, a former professor of electrical engineering at the Ohio State University, and his brother David, Lake Shore produces equipment for the measurement of cryogenic temperatures, magnetic fields, and the characterization of the physical properties of materials in temperature and magnetic environments.

